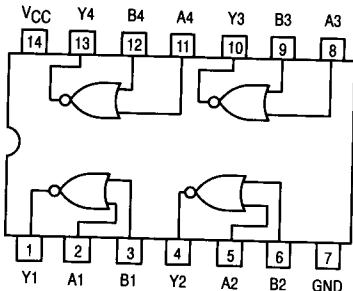




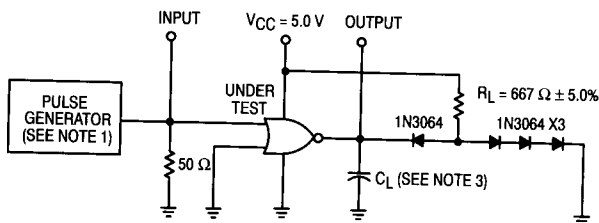
Quad 2-Input Positive NOR Buffer

ELECTRICALLY TESTED PER:
MIL-M-38510/30204

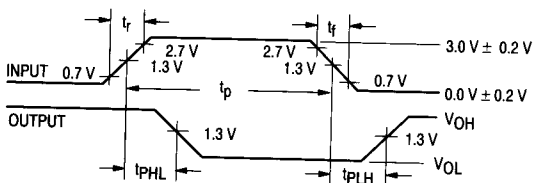
LOGIC DIAGRAM



AC TEST CIRCUIT



WAVEFORMS



NOTES:

1. Pulse generator has the following characteristics: $t_r \leq 15$ ns, $t_f \leq 6.0$ ns, $PRR \leq 1.0$ MHz, $t_p = 200$ ns ± 20 ns and $Z_{OUT} \approx 50 \Omega$.
2. All diodes are 1N3064 or equivalent.
3. $C_L = 125$ pF $\pm 10\%$, including scope probe, wiring and stray capacitance, without package in test fixture.
4. $R_L = 667 \Omega \pm 5.0\%$.
5. Voltage measurements are to be made with respect to network ground terminal.
6. Terminal conditions (pins not designated may be high ≥ 2.0 V, low ≤ 0.7 V, or open).

Military 54LS28



AVAILABLE AS:

- 1) JAN: JM38510/30204BXA
- 2) SMD: N/A
- 3) 883: 54LS28/BXAJC

X = CASE OUTLINE AS FOLLOWS:
PACKAGE: CERDIP: C
CERFLAT: D
LCC: 2

THE LETTER "M" APPEARS BEFORE THE / ON LCC.

PIN ASSIGNMENTS

FUNCT.	PIN ASSIGNMENTS			BURN-IN (COND. A)
	DIL 632-08	FLATS 717-04	LCC 756A-02	
Y1	1	1	2	VCC
A1	2	2	3	GND
B1	3	3	4	GND
Y2	4	4	6	VCC
A2	5	5	8	GND
B2	6	6	9	GND
GND	7	7	10	GND
A3	8	8	12	GND
B3	9	9	13	GND
Y3	10	10	14	VCC
A4	11	11	16	GND
B4	12	12	18	GND
Y4	13	13	19	VCC
VCC	14	14	20	VCC

BURN-IN CONDITIONS:
 $V_{CC} = 5.0$ V MIN/ 6.0 V MAX

TRUTH TABLE

A	B	Y
0	0	1
0	1	0
1	0	0
1	1	0

54LS28

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
		+ 25°C		+ 125°C		- 55°C			
		Subgroup 1		Subgroup 2		Subgroup 3			
		Min	Max	Min	Max	Min	Max		
V _{OH}	Logical "1" Output Voltage	2.5		2.5		2.5		V	V _{CC} = 4.5 V, I _{OH} = - 1.2 mA, V _{IL} = 0.7 V, other input = 0.7 V.
V _{OL}	Logical "0" Output Voltage		0.4		0.4		0.4	V	V _{CC} = 4.5 V, I _{OL} = 12 mA, V _{IH} = 2.0 V other input = 0 V.
V _{IC}	Input Clamping Voltage		- 1.5					V	V _{CC} = 4.5 V, I _{IN} = - 18 mA, other input is open.
I _{IH1}	Logical "1" Input Current		20		20		20	μA	V _{CC} = 5.5 V, V _{IN} = 2.7 V, other input = 0 V.
I _{IH2}	Logical "1" Input Current		100		100		100	μA	V _{CC} = 5.5 V, V _{IN} = 5.5 V, other input = 0 V.
I _{IL}	Logical "0" Input Current	-160	- 400	-160	- 400	-160	- 400	μA	V _{CC} = 5.5 V, V _{IN} = 0.4 V, other input = 5.5 V.
I _{OS}	Output Short Circuit Supply	- 30	-130	- 30	-130	- 30	-130	mA	V _{CC} = 5.5 V, V _{IN} = 0 V (all inputs), V _{OUT} = 0 V.
I _{CCH}	Power Supply Current		3.6		3.6		3.6	mA	V _{CC} = 5.5 V, V _{IN} = 0 V (all inputs).
I _{CCL}	Power Supply Current		13.8		13.8		13.8	mA	V _{CC} = 5.5 V, V _{IN} = 5.5 V (all inputs).
V _{IH}	Logical "1" Input Voltage	2.0		2.0		2.0		V	V _{CC} = 4.5 V.
V _{IL}	Logical "0" Input Voltage		0.7		0.7		0.7	V	V _{CC} = 4.5 V.
	Functional Tests	Subgroup 7		Subgroup 8A		Subgroup 8B			per Truth Table with V _{CC} = 5.0 V, V _{INL} = 0.5 V, and V _{INH} = 2.5 V.

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Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
		+ 25°C		+ 125°C		- 55°C			
		Subgroup 9		Subgroup 10		Subgroup 11			
		Min	Max	Min	Max	Min	Max		
t _{PHL} t _{PHL}	Propagation Delay /Data-Output Output High-Low	2.0	25	2.0	30	2.0	30	ns	V _{CC} = 5.0 V, C _L = 125 pF, R _L = 667 Ω. V _{CC} = 5.0 V, C _L = 45 pF, R _L = 667 Ω.
t _{PLH} t _{PLH}	Propagation Delay /Data-Output Output Low-High	2.0	25	2.0	30	2.0	30	ns	V _{CC} = 5.0 V, C _L = 125 pF, R _L = 667 Ω. V _{CC} = 5.0 V, C _L = 45 pF, R _L = 667 Ω.

NOTE:

1. The limits specified for C_L = 45 pF are guaranteed but not tested.